

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 194715US-2 CONT		SERIAL NO. 09/632,221	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT TAKAFUMI ITOH, ET AL.		GROUP	
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<div style="font-size: 2em;">11/</div>	AO	JP 4-168478	06/16/92	Japan (with English abstract)			x
	AP	JP 8-69271	03/12/96	Japan (with English abstract)			x
	AQ	JP 4-205476	07/27/92	Japan (with English abstract)			x
	AR	JP 60-176093	09/10/85	Japan (with English abstract)			x
	AS	JP 60-232597	11/19/85	Japan (with English abstract)			x
	AT	JP 6-86165	03/25/94	Japan (with English abstract)			x
	AU	JP 59-276	01/05/84	Japan (with English abstract)			x
	AV	JP 62-276672	12/01/87	Japan (with English abstract)			x

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)	
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Examiner <i>Mundia Beliz</i>	Date Considered 11/04/02
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FOREIGN PATENT DOCUMENTS							
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<i>ne</i> ↓	AO JP 5-183853	07/23/93	Japan (with English abstract)				
	AP JP 56-27195	03/16/81	Japan (with English abstract)				
	AQ JP 4-284495	10/09/92	Japan (with English abstract)				
	AR JP 5-046135	02/26/93	Japan (with English abstract)				
	AS JP 6-295339	10/21/94	Japan (with English abstract)				
	AT JP 56-067445	06/06/81	Japan (with English abstract)				
	AU						
	AV						

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)	
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Examiner <i>M. B. ...</i>	Date Considered <i>11/04/02</i>
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